



033216 M 073

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): Hirofumi WADA

U.S. Serial No.: 09/845,315 Group Art Unit: 2616

Filed: May 1, 2001 Examiner: Robert Chevalier

For: DATA RECORDING SYSTEM AND RECORDING OBJECTIVE
DETERMINATION DEVICE

THIRD INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
Washington, D.C. 20231

Sir:

This Information Disclosure Statement is filed concurrent with a Request for Continued Examination. Pursuant to the duty of disclosure under 37 C.F.R. 1.56, Applicant encloses an Information Disclosure Citation Form (PTO-1449) and copy of the documents cited therein.

Of the documents listed on the enclosed Form PTO-1449, documents AA and AL are counterparts. Documents AB and AM also are counterparts.

It is respectfully requested that the cited documents be considered by the Examiner in the above-identified patent application and that the cited documents be made officially of record therein. It is further requested that a listing of the same appear on the face of any patent which may issue from this application.

Respectfully submitted,
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FORM PTO-1449 INFORMATION DISCLOSURE STATEMENT		ATTY. DOCKET 033216M073	SERIAL NO. 09/845,315
		APPLICANT: Hirofumi WADA	
		FILING DATE May 1, 2001	GROUP ART UNIT 2616

U.S. PATENT DOCUMENTS

*Examiner's Initials		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE, IF APPROPRIATE
	AA	5,838,577	November 17, 1998	Tokano			
	AB	6,678,462	January 13, 2004	Chihara			
	AC						
	AD						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS

*Examiner's Initials		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION YES NO
	AL	7-182768	7/21/1995	JAPAN			X
	AM	10-269754	10/9/1998	JAPAN			X
	AN	9-25915	10/3/1997	JAPAN			X
	AO	11-205313	7/30/1999	JAPAN			X
	AP	2000-47829	2/18/2000	JAPAN			X

OTHER INFORMATION (Including Author, Title, Date, Pertinent Pages, Etc.)

AQ	Copy of Japan Patent Office Action mailed on February 14, 2006
AR	
EXAMINER:	DATE CONSIDERED:

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.